	h Not	•	

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/721,786	JUN, JUNG SIG	
	Examiner	Art Unit	
	Krista M. Flanagan	2631	

SEARCHED			
Class	Subclass	Date	Examiner
375	326 316 321 350 261 340	5/26/2005	KMF
348	325 725	5/26/2005	KMF
348	726	5/26/2005	KMF
329	304 306	5/26/2005	KMF
329	307 308	5/26/2005	KMF
375	270	5/26/2005	KMF
329	357	5/26/2005	KMF
375	327 355	5/26/2005	KMF
•			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
375	326	2/21/2006	KMF
	<u> </u>		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST	5/26/2005	KMF
Inventor Search	5/26/2005	KMF
Updated Search - See Search Notes for Details	2/21/2006	KMF